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Journal of  
**APPLIED PHYSICS**

Applied Physics Review:  
Quantitative Emission Spectroscopy  
by J. Kölzer, C. Boit, A. Dallmann,  
G. Deboy, J. Otto, and D. Weinmann

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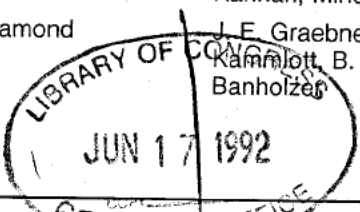
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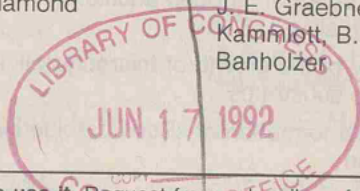
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